Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/568,640	NAKANO, YOICHI
Examiner	Art Unit
Sameh H. Tawfik	3721

SEARCHED				
Class	Subclass	Date	Examiner	
53	553	1/22/2008	ST.	
	576			
	567			
	575		_	
	570			
	574			
	459			
	457			
	468			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
53	All-Above	1/22/2008	ST.	
	-l			

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
Inventor text search.	1/22/2008	ST.
		ه خو